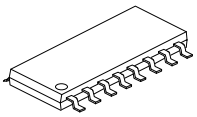
U74HCT165

CMOS IC

8-BIT PARALLEL-LOAD SHIFT REGISTER



SOP-16

■ DESCRIPTION

The **U74HCT165** is an 8-bit parallel-load shift register that, when clocked, shifts the data toward a serial (Q_H) output. Parallel-in access to each stage is provided by eight individual direct data (A-H) inputs these are enabled by a low level at shift/load (SH/$\overline{LD}$) input. The U74HCT165 also features a clock-inhibit (CLK INH) function and a complementary serial ($\overline{Q}_H$) output.

Clocking is accomplished by a low-to-high transition of the clock (CLK) input while SH/$\overline{LD}$ is held high and CLK INH is held low. The functions of CLK and CLK INH are interchangeable. Since a low CLK and a low-to-high transition of CLK INH also accomplish clocking, CLK INH should be changed to the high level only while CLK is high. Parallel loading is inhibited when SH/$\overline{LD}$ is held high. While SH/$\overline{LD}$ is low, the parallel inputs to the register are enabled independently of the levels of the CLK, CLK INH, or serial (SER) inputs.

The inputs are compatible with TTL,NMOS and CMOS output voltage levels.

■ FEATURES

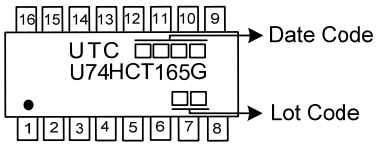
* Complementary Outputs
* Direct Overriding Load (Data) Inputs
* Gated Clock Inputs
* Parallel-to-Serial Data Conversion
* Compatible with TTL, NMOS, CMOS output voltage levels

■ ORDERING INFORMATION

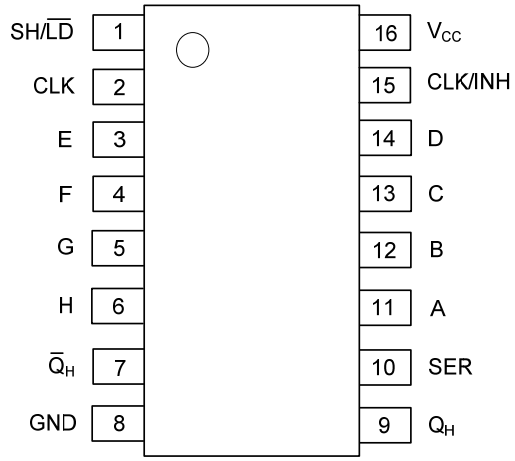
Ordering Number	Package	Packing
U74HCT165G-S16-R	SOP-16	Tape Reel

U74HCT165G-S16-R (1) Packing Type (2) Package Type (3) Green Package	(1) R: Tape Reel (2) S16: SOP-16 (3) G: Halogen Free and Lead Free

■ MARKING



■ PIN CONFIGURATION

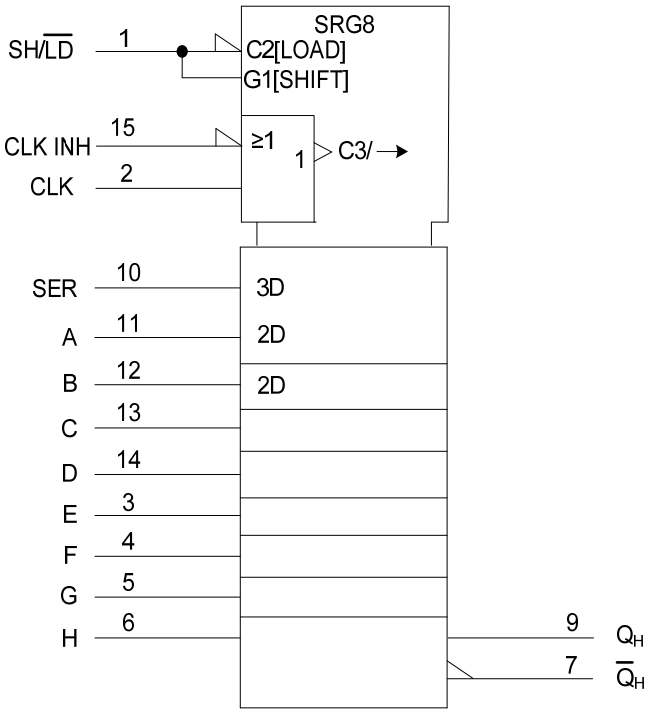


■ FUNCTION TABLE

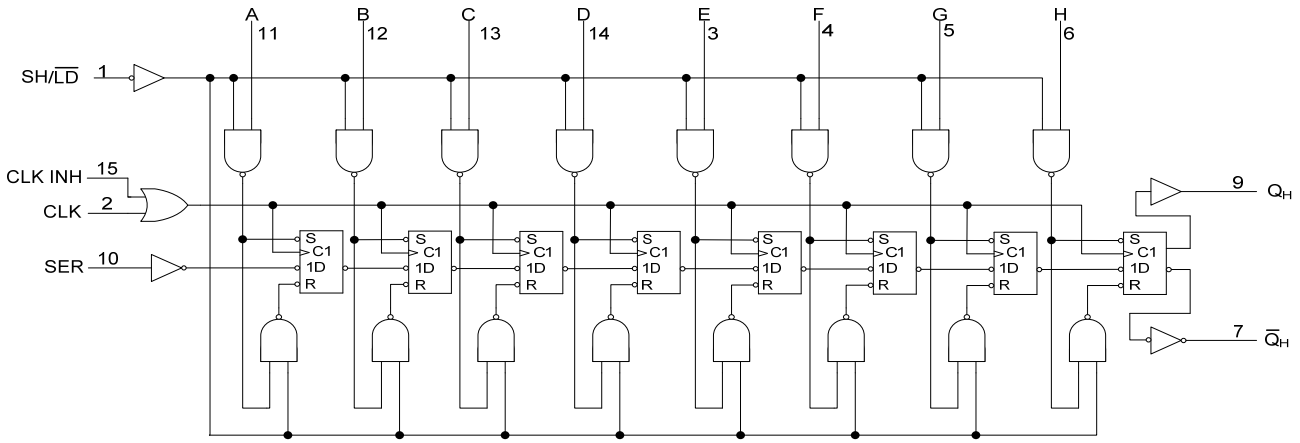
Operating Modes	Inputs					Qn Registers		Outputs	
	SH/$\overline{LD}$	CLK/INH	CLK	SER	A to H	Q0	Q1 to Q6	Q_H	$\overline{Q}_H$
Parallel Load	L	X	X	X	L	L	L to L	L	H
	L	X	X	X	H	H	H to H	H	L
Serial Shift	H	L	↑	l	X	L	q0 to q 5	q6	$\overline{q6}$
	H	L	↑	h	X	H	q0 to q 5	q6	$\overline{q6}$
	H	↑	L	l	X	L	q0 to q 5	q6	$\overline{q6}$
	H	↑	L	h	X	H	q0 to q 5	q6	$\overline{q6}$
Hold “Do Nothing”	H	H	X	X	X	Q0	q1 to q6	q7	$\overline{q7}$
	H	X	H	X	X	Q0	q1 to q6	q7	$\overline{q7}$

Notes: H=HIGH Voltage Level;
h= HIGH Voltage Level one set-up time prior to the LOW-to-HIGH clock transition;
L=LOW Voltage Level;
l= LOW Voltage Level one set-up time prior to the LOW-to-HIGH clock transition;
q=state of the referenced output one set-up time prior to the LOW-to-HIGH clock transition;
X=don’t care;
↑= LOW-to-HIGH clock transition.

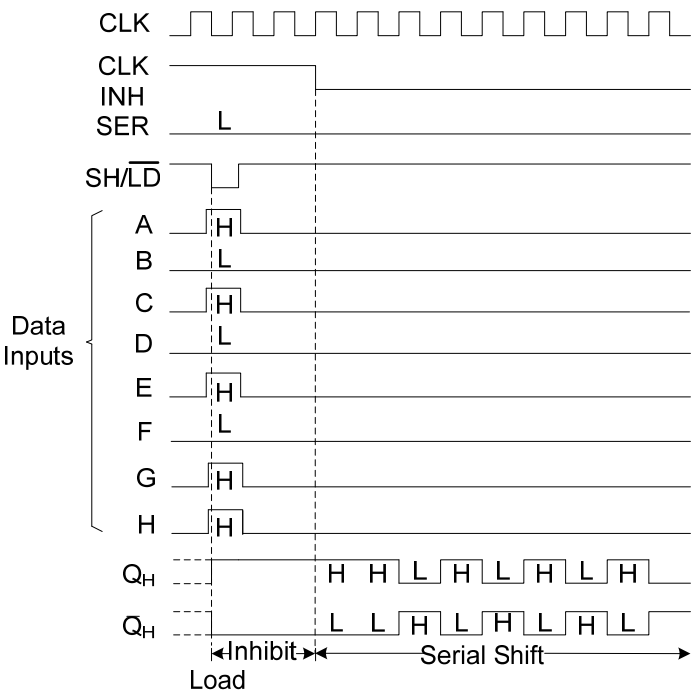
■ LOGIC SYMBOL



■ LOGIC DIAGRAM (positive logic)



■ TYPICAL SHIFT, LOAD, AND INHIBIT SEQUENCE



■ ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V_{CC}	-0.5 ~ 7	V
V_{CC} or GND Current	I_{CC}	±50	mA
Output Current	I_{OUT}	±25	mA
Input Clamp Current	I_{IK}	±20	mA
Output Clamp Current	I_{OK}	±20	mA
Storage Temperature	T_{STG}	-65 ~ + 150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}		4.5	5	5.5	V
High-level Input Voltage	V_{IH}	V_{CC}=4.5V	2			V
		V_{CC}=5.5V	2			V
Low-level Input Voltage	V_{IL}	V_{CC}=4.5V			0.8	V
		V_{CC}=5.5V			0.8	V
Input Voltage	V_{IN}		0		V_{CC}	V
Output Voltage	V_{OUT}		0		V_{CC}	V
Input Transition (Rise and Fall) Time	t_t	V_{CC}=4.5V			500	ns
Operating Free-air Temperature	T_A		-40		+125	°C

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	73	°C/W

■ ELECTRICAL CHARACTERISTICS (T_A =25°C , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output Voltage High-Level	V_{OH}	V_{CC}=4.5V, I_{OH}=-20μA	4.4	4.5		V
		V_{CC}=4.5V, I_{OH}=-4mA	3.98	4.32		V
Output Voltage Low-Level	V_{OL}	V_{CC}=4.5V, I_{OH}=20μA		0	0.1	V
		V_{CC}=4.5V, I_{OL}=4mA		0.15	0.26	V
Input Leakage Current	$I_{I(LEAK)}$	V_{CC}=5.5V, V_{IN}= V_{CC} or GND			±100	nA
Quiescent Supply Current	I_{CC}	V_{CC}=5.5V, V_{IN}=V_{CC} or GND			8	μA
Additional supply current	$\triangle I_{CC}$	V_I=V_{CC}-2.1V,other inputs at V_{CC} or GND,V_{CC}=4.5V to 5.5V, DS, Dn inputs		35	126	uA
		V_I=V_{CC}-2.1V, other inputs at V_{CC} or GND, V_{CC}=4.5V to 5.5V, $\overline{CLK}$,CLKINH,$\overline{SH/LD}$ inputs		65	234	uA
Input Capacitance	C_I			3.5		pF

■ TIMING REQUIREMENTS (T_A =25°C , unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Clock frequency		f_{CLOCK}	V_{CC}=4.5V	26	44		MHz
			V_{CC}=5V, C_L=15pF		48		MHz
Pulse duration	CLK high input	t_W	V_{CC}=4.5	16	6		ns
	SH/$\overline{LD}$ low input		V_{CC}=4.5V	20	9		ns
Setup time	DS before CLK,CLK INH	t_{SU}	V_{CC}=4.5V	20	2		ns
	CLK INH to CLK, CLK to CLK INH		V_{CC}=4.5V	20	7		ns
	Dn to SH/$\overline{LD}$		V_{CC}=4.5V	20	10		ns
Hold time	DS to CLK，CLK INH	t_h	V_{CC}=4.5V	7			ns
	CLK to CLK INH，CLK INH to CLK		V_{CC}=4.5V	0			ns

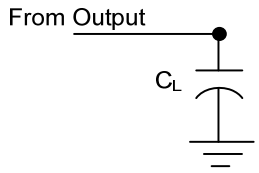
■ SWITCHING CHARACTERISTICS (t_r = t_f = 6ns, C_L=50pF, T_A =25°C, unless otherwise specified)

PARAMETER	SYMBOL	Condition	MIN	TYP	MAX	UNIT
Propagation delay FROM SH/$\overline{LD}$ to QH or $\overline{Q}_H$	t_{PD}	V_{CC}=4.5V		20	40	ns
		V_{CC}=5V, C_L=15pF		17		Ns
Propagation delay FROM CLK, CLK, INH to QH or $\overline{Q}_H$		V_{CC}=4.5V		17	40	Ns
		V_{CC}=5V, C_L=15pF		14		Ns
Propagation delay FROM D7 to QH or $\overline{Q}_H$		V_{CC}=4.5V		14	35	Ns
		V_{CC}=5V, C_L=15pF		11		ns
FROM QH or $\overline{Q}_H$	t_t	V_{CC}=4.5V		7	15	ns

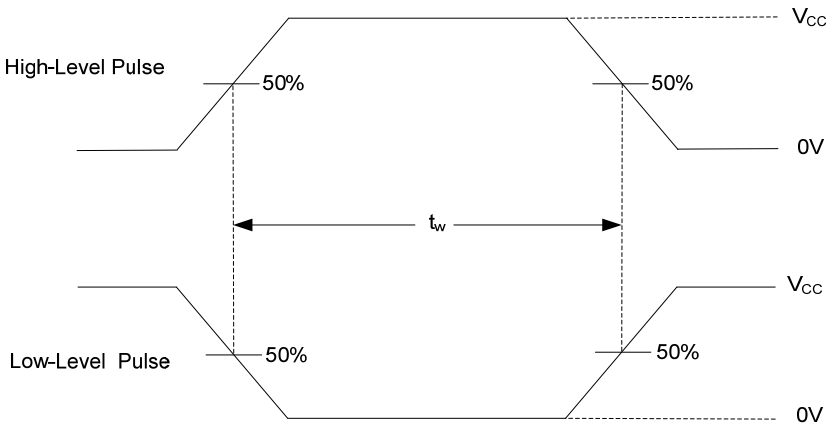
■ OPERATING CHARACTERISTICS (T_A =25°C , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C_{PD}	No load		35		pF

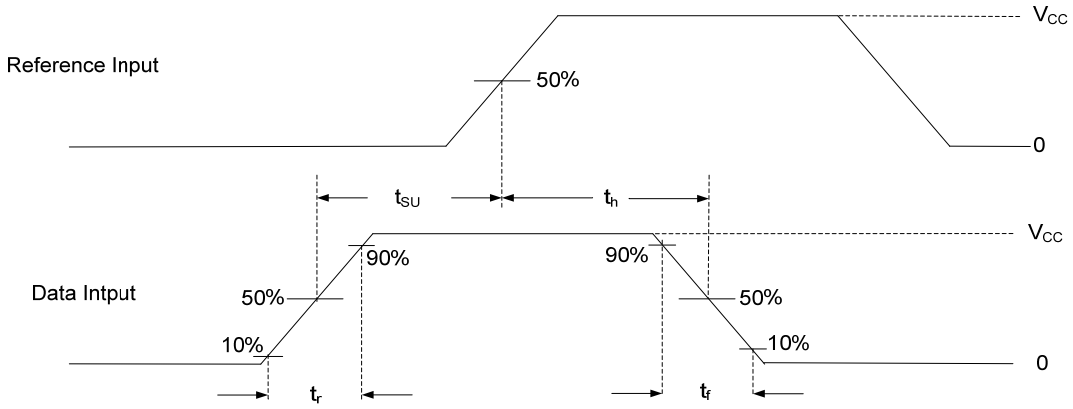
■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

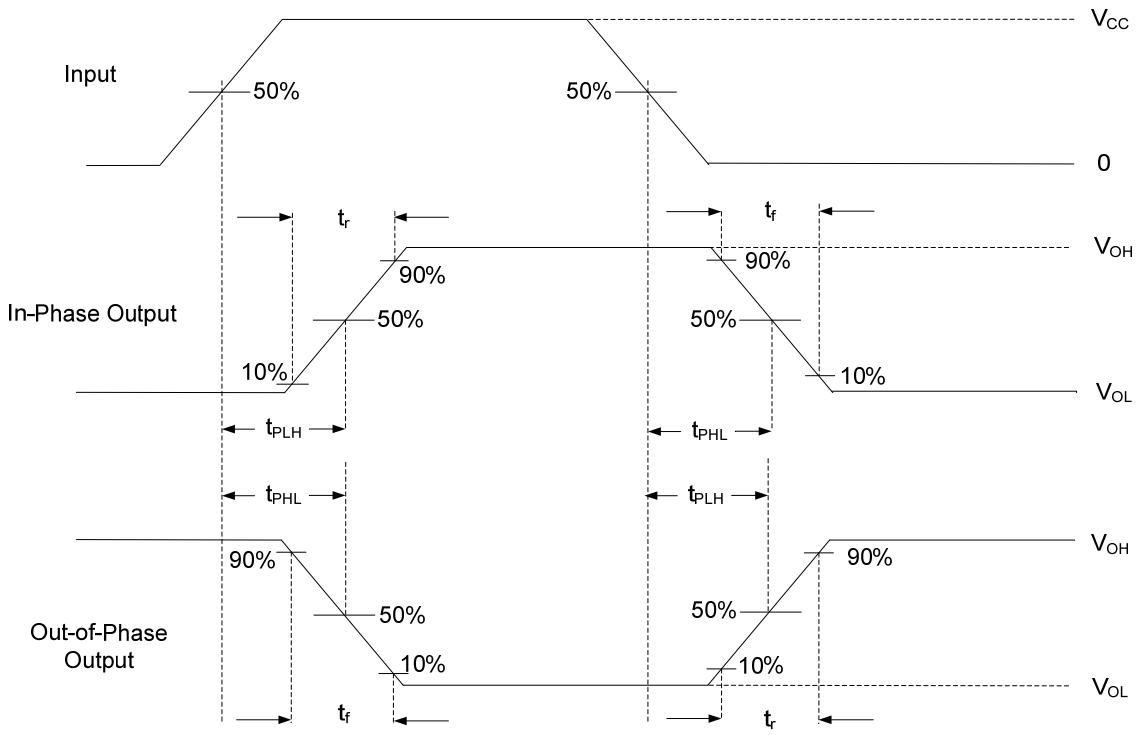


PULSE DURATIONS



SET AND HOLD AND INPUT RISE AND FALL TIMES

■ TEST CIRCUIT AND WAVEFORMS (Cont.)



PROPAGATION DELAY AND OUTPUT TRANSITION TIMES